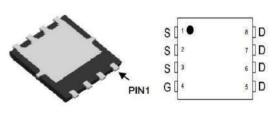


Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low RDS(ON)

Application

- DC-DC Converters
- Power management functions
- Synchronous-rectification applications

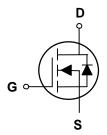




Product Summary



V _{DS}	40	V
R DS(on),Max@ VGS=10 V	1.5	mΩ
1 р	120	Α



■ Absolute Maximum Ratings (T_A=25 °C unless otherwise noted)

Parameter		Symbol	Limit	Unit	
Drain-source Voltage		V _{DS}	40	V	
Gate-source Voltage		V_{GS}	±20	V	
Drain Current (Silicon limited)		I _D	200	А	
Drain Current ^A	T _C =25℃		120	А	
	T _C =100℃	- I _D	82		
Pulsed Drain Current ^B		I _{DM}	360	А	
Avalanche energy ^c		Eas	450	mJ	
Total Power Dissipation ^D		P _D	114	W	
Thermal Resistance Junction-to-Case		R _{eJC}	1.1	- °C/ W	
Thermal Resistance Junction-to-Ambient ^E		$R_{ heta JA}$	20		
Junction and Storage Temperature Range		T _J ,T _{STG}	-55∼+150	$^{\circ}$	



■ Electrical Characteristics (T_J=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Тур	Max	Units
Static Parameter			- 1	1		
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D =250μA	40			٧
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =40V,V _{GS} =0V			1	μΑ
Gate-Body Leakage Current	I _{GSS}	V_{GS} = ± 20 V, V_{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V_{DS} = V_{GS} , I_D =250 μ A	2.2		3.8	V
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D =20A			1.5	mΩ
Gate Resistance	R _g	V _{GS} =0V,V _{DS} Open,f=1MHZ		2.7		Ω
Maximum Body-Diode Continuous Current	Is				120	Α
Dynamic Parameters						
Input Capacitance	C _{iss}			9300		
Output Capacitance	Coss	V_{DS} =25V, V_{GS} =0V,f=300KHZ		1410		pF
Reverse Transfer Capacitance	C _{rss}			78		
Switching Parameters			-1	1		
Total Gate Charge	Qg			127		
Gate-Source Charge	Q_{gs}	V_{GS} =10V, V_{DS} =32V, I_{D} =20A		35		0
Gate-Drain Charge	Q_{gd}			26		nC
Reverse Recovery Chrage	Q _{rr}	L 05A 45/44 400A/v		163		
Reverse Recovery Time	t _{rr}	I _F =25A, di/dt=100A/us		100		
Turn-on Delay Time	t _{d(on)}			22.5		
Turn-on Rise Time	t _r	V _{GS} =10V,V _{DD} =20V,I _D =25A		6.7		ns
Turn-off Delay Time	t _{d(off)}	R_{GEN} =2 Ω		80.3		
Turn-off fall Time	t _f			26.9		

Note:

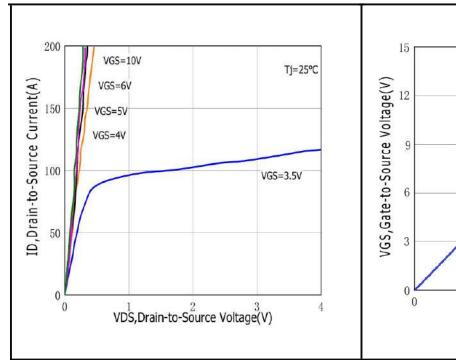
- A. The maximum current rating is package limited.
- B. Repetitive rating; pulse width limited by max. junction temperature.
- $\label{eq:DDD} \textbf{D.} \quad \textbf{P}_{\textbf{D}} \, \text{is based on max. junction temperature, using junction-case thermal resistance.}$
- E. The value of R_{BJA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with Ta=25 °C.



■ Typical Performance Characteristics

Figure.1 Typical Output Characteristics

Figure.2 Typical Gate Charge vs Gate to Source Voltage



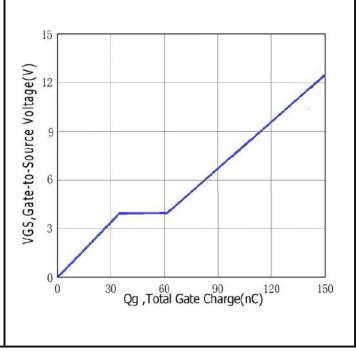
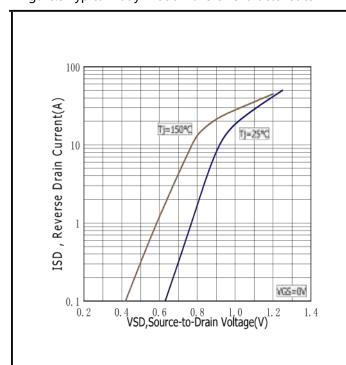
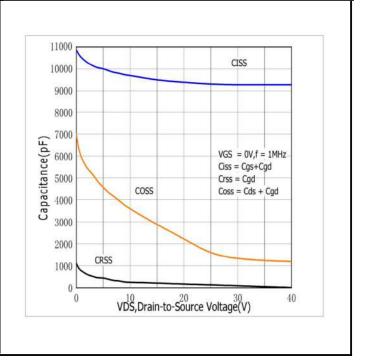


Figure.3 Typical Body Diode Transfer Characteristics

Figure.4 Typical Capacitance vs Drain to Source Voltage



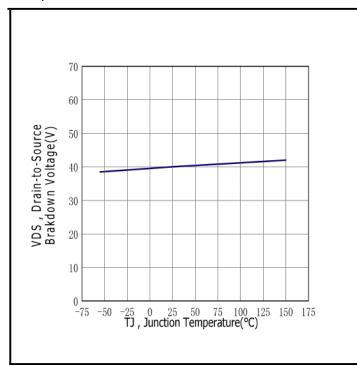




■ Typical Performance Characteristics

Figure.5 Typical Breakdown Voltage vs Junction Temperature

Figure.6 Typical Drain to Source on Resistance vs Junction Temperature



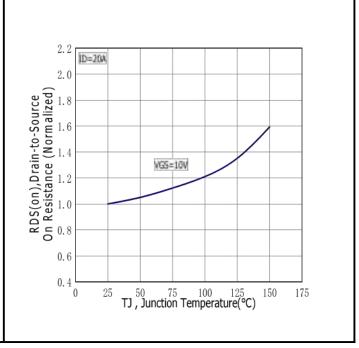
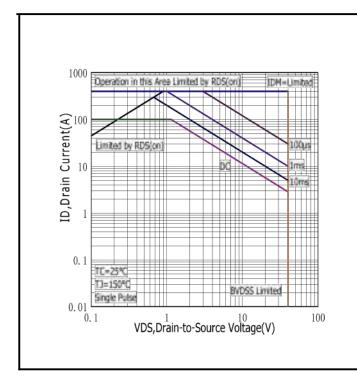
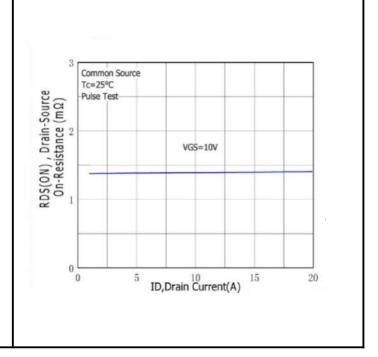


Figure.7 Maximum Forward Bias Safe Operating Area

Figure.8 Typical Drain to Source ON Resistance vs Drain Current



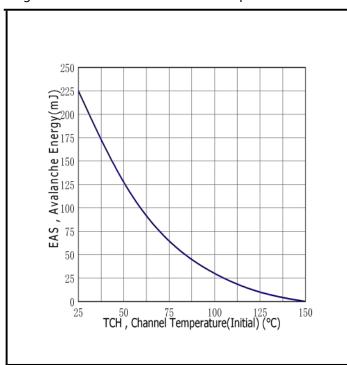




■ Typical Performance Characteristics

Figure.9 Maximum EAS vs Channel Temperature

Figure.10 Typical Threshold Voltage vs Case Temperature



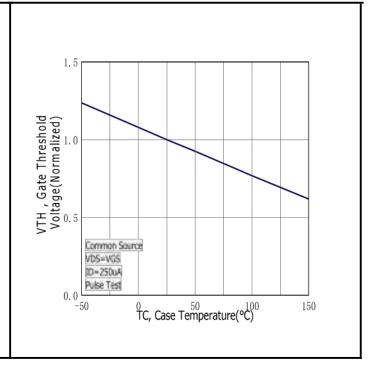
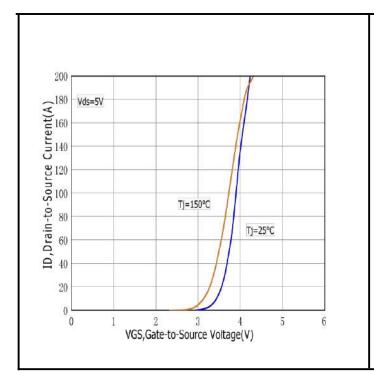


Figure.11 Typical Transfer Characteristics

Figure.12 Maximum Power Dissipation vs Case Temperature



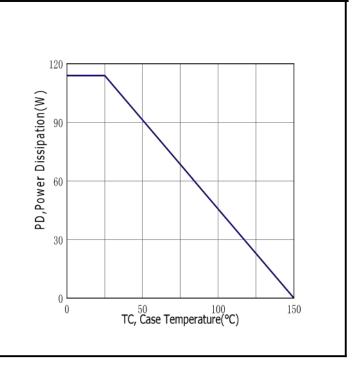
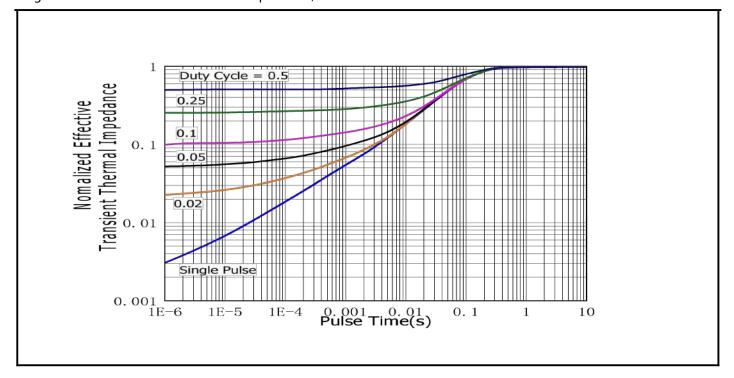




Figure.13 Maximum Effective Thermal Impedance, Junction to Case





■ Test circuits and waveforms

Figure A: Gate Charge Test Circuit & Waveforms

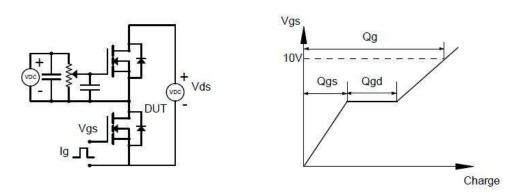


Figure B: Resistive Switching Test Circuit & Waveforms

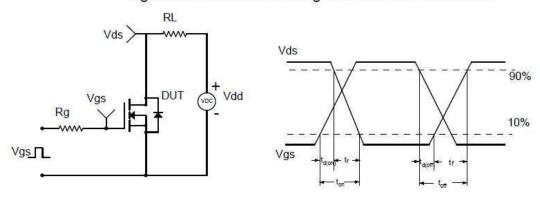


Figure C: Unclamped Inductive Switching (UIS) Test

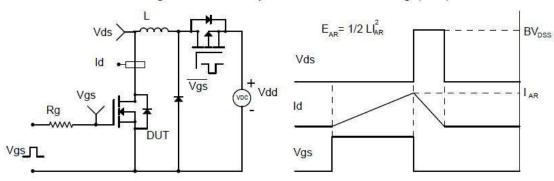
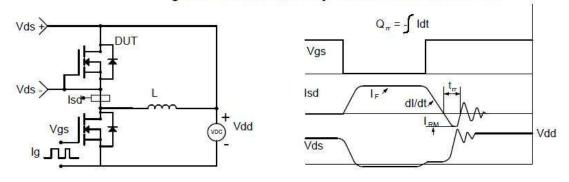


Figure D: Diode Recovery Test Circuit & Waveforms





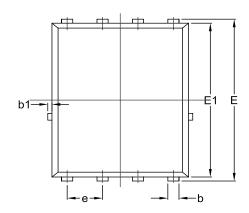
Ordering and Marking Information

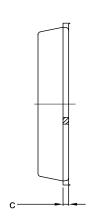
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ASDM40R015NHQ-R	40R015NH	PDFN5*6-8	Tape&Reel	4000/Reel

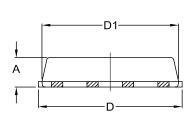
PACKAGE	MARKING		
PDFN5*6-8	AS □□□ → Lot Number 40R015NH □□□□ → Date Code		

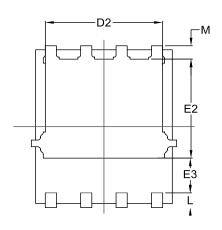
8/10











Notes:

1.Dimension D1 ,E1 not included mold flash

DIM	MILLIMETERS			
	MIN	NOM	MAX	
А	1.00	1.10	1.20	
b	0.30	0.40	0.50	
b1	0.02	0.15	0.22	
С	0.15	0.20	0.35	
D	4.95	5.25	5.45	
D1	4.80	4.90	5.00	
D2	4.00	4.20	4.40	
E	5.95	6.05	6.25	
E1	5.65	5.75	5.85	
E2	3.30	3.60	3.90	
E3	1.10	1	/	
е	1.27			
Ĺ	0.38	0.55	0.70	
M	0.35	0.50	0.65	





40V N-Channel MOSFET

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